

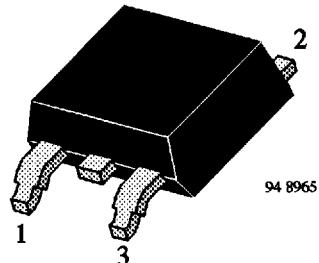
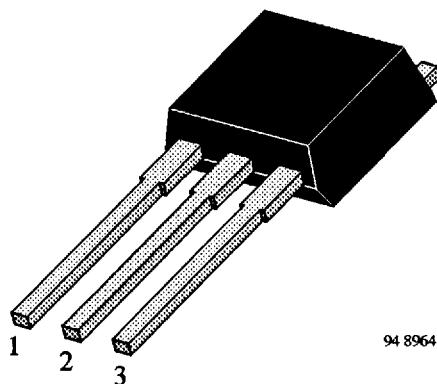
Silicon NPN High Voltage Switching Transistor

Features

- Multi diffusion technology
- Glass passivation
- High reverse voltage
- Short switching times

Applications

Electronic lamp ballast circuits
Switch-mode power supplies



BUD86
BUD87
1 Emitter 2 Collector 3 Base

BUD86 -SMD
BUD87 -SMD
1 Emitter 2 Collector 3 Base

Absolute Maximum Ratings

$T_{case} = 25^\circ\text{C}$, unless otherwise specified

Parameter	Test Conditions	Type	Symbol	Value	Unit
Collector-emitter voltage		BUD86	V_{CEO}	400	V
		BUD87	V_{CEO}	450	V
		BUD86	V_{CES}	800	V
		BUD87	V_{CES}	1000	V
Emitter-base voltage			V_{EBO}	5	V
Collector current			I_C	0.5	A
Collector peak current			I_{CM}	1	A
Base current			I_B	0.3	A
			$-I_B$	0.3	A
Total power dissipation	$T_{case} \leq 60^\circ\text{C}$		P_{tot}	20	W
Junction temperature			T_j	150	$^\circ\text{C}$
Storage temperature range			T_{stg}	-65 to +150	$^\circ\text{C}$

Maximum Thermal Resistance $T_{case} = 25^\circ\text{C}$, unless otherwise specified

Parameter	Test Conditions	Symbol	Value	Unit
Junction case		R_{thJC}	4.5	K/W

Electrical Characteristics $T_{case} = 25^\circ\text{C}$, unless otherwise specified

Parameter	Test Conditions	Type	Symbol	Min	Typ	Max	Unit
Collector cut-off current	$V_{CE} = 800 \text{ V}$	BUD86	I_{CES}			100	μA
	$V_{CE} = 1000 \text{ V}$	BUD87	I_{CES}			100	μA
	$V_{CE} = 800 \text{ V}; T_{case} = 125^\circ\text{C}$	BUD86	I_{CES}			1	mA
	$V_{CE} = 1000 \text{ V}; T_{case} = 125^\circ\text{C}$	BUD87	I_{CES}			1	mA
Collector-emitter breakdown voltage (figure 1)	$I_C = 100 \text{ mA}; L = 125 \text{ mH}; I_{measure} = 50 \text{ mA}$	BUD86	$V_{(BR)CEO}$	400			V
		BUD87	$V_{(BR)CEO}$	450			V
Emitter-base breakdown voltage	$I_E = 1 \text{ mA}$		$V_{(BR)EBO}$	5			V
Collector-emitter saturation voltage	$I_C = 100 \text{ mA}; I_B = 10 \text{ mA}$		V_{CESat}			0.8	V
	$I_C = 200 \text{ mA}; I_B = 20 \text{ mA}$		V_{CESat}			1	V
Base-emitter saturation voltage	$I_C = 200 \text{ mA}; I_B = 20 \text{ mA}$		V_{BEsat}			1	V
DC forward current transfer ratio	$V_{CE} = 5 \text{ V}; I_C = 50 \text{ mA}$		h_{FE}		50		
Gain bandwidth product	$I_C = 50 \text{ mA}; V_{CE} = 10 \text{ V}; f = 1 \text{ MHz}$		f_T		20		MHz

Switching Characteristics $T_{case} = 25^\circ\text{C}$, unless otherwise specified

Parameter	Test Conditions	Type	Symbol	Min	Typ	Max	Unit
Resistive load (figure 2)							
Storage time	$I_C = 400 \text{ mA}; I_{B1} = 20 \text{ mA}; -I_{B2} = 40 \text{ mA}; V_S = 125 \text{ V}$		t_s			3.5	μs
Fall time			t_f		0.4		μs

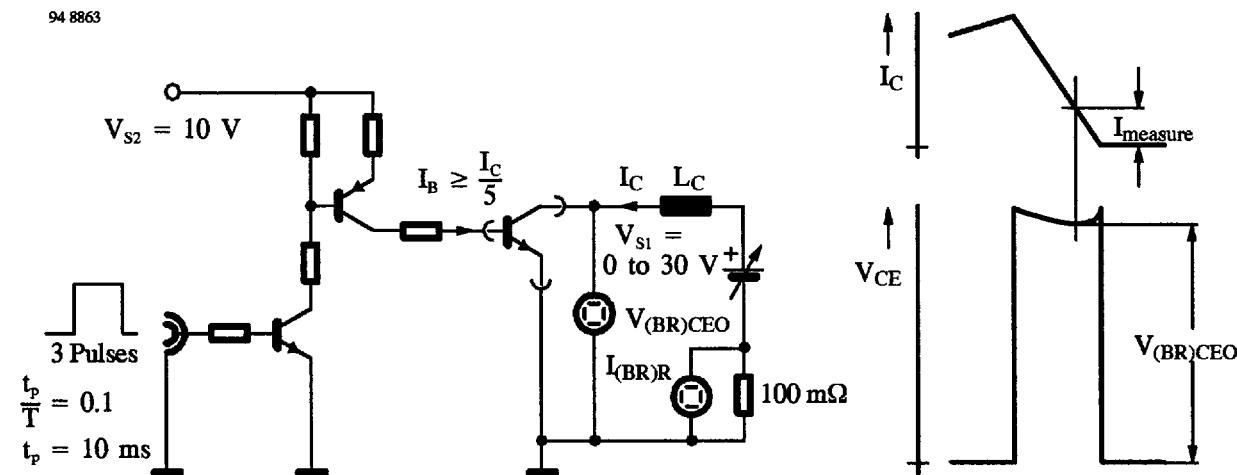


Figure 1. Test circuit for $V_{(BR)CEO}$

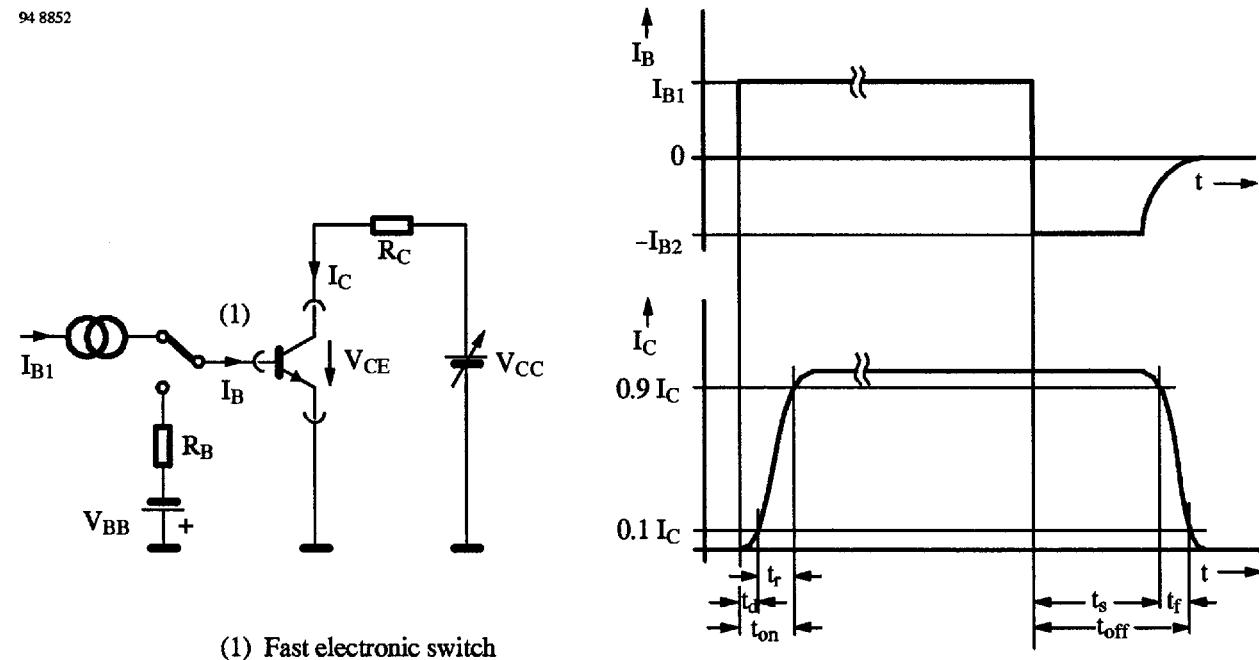
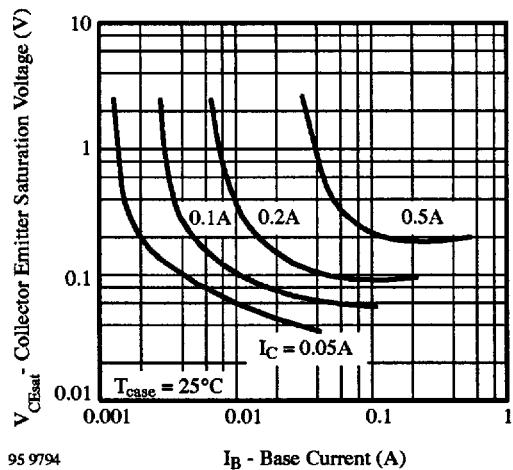
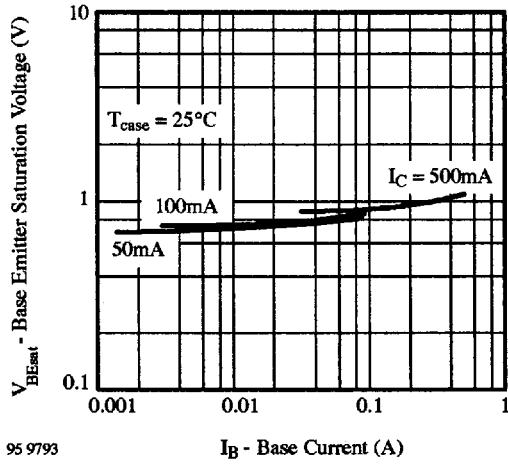


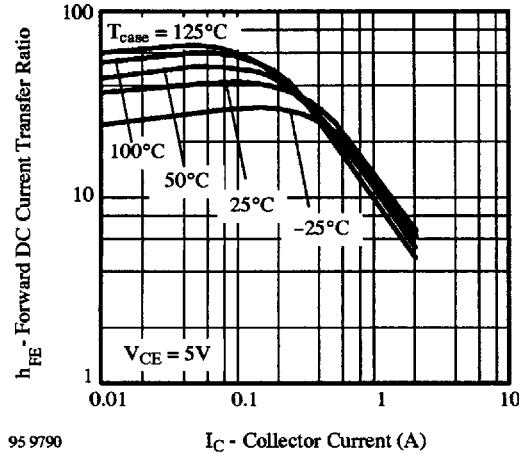
Figure 2. Test circuit for switching characteristics - resistive load

Typical Characteristics ($T_{case} = 25^\circ C$ unless otherwise specified)

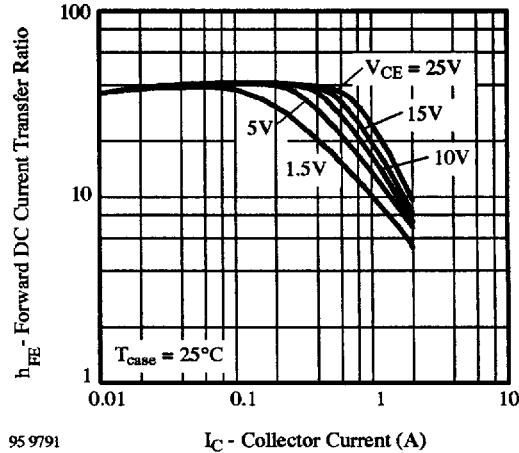
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Figure 3. V_{CEsat} vs. I_B 

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Figure 5. V_{BEsat} vs. I_B 

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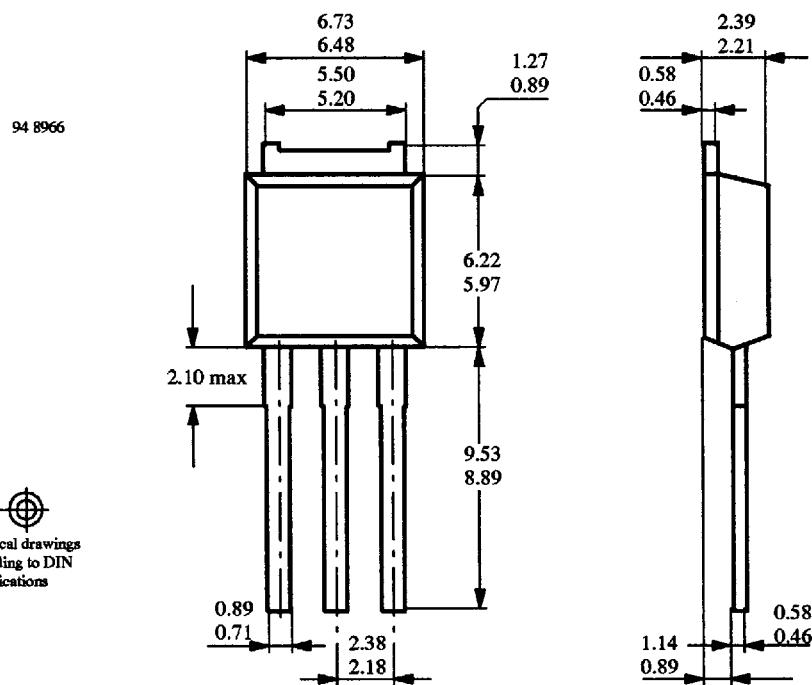
Figure 4. h_{FE} vs. I_C 

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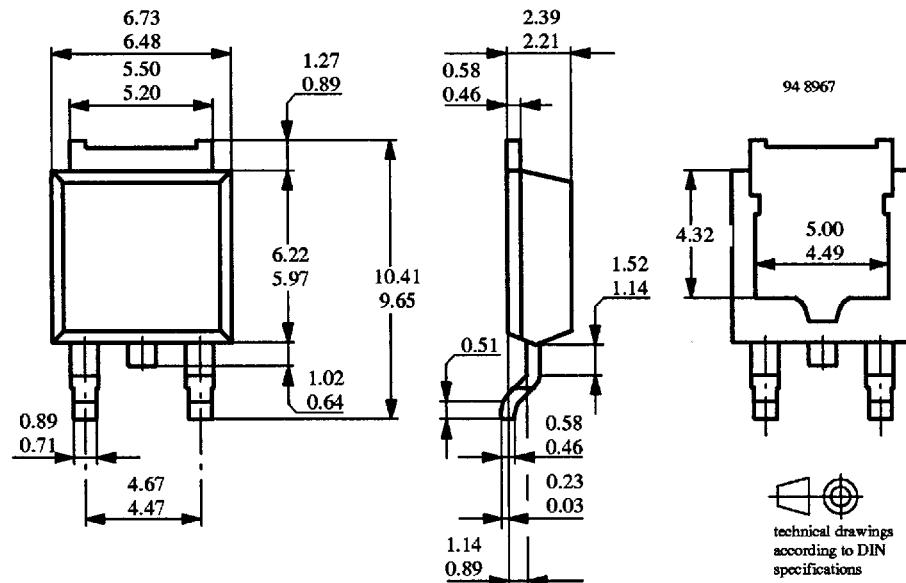
Figure 6. h_{FE} vs. I_C

Dimensions in mm

TO251



TO252



For ordering TO 252 add SMD to the type number (i.e. BUD86-SMD)